Dear customer

LAPIS Semiconductor Co., Ltd. ("LAPIS Semiconductor"), on the 1st day of October, 2020, implemented the incorporation-type company split (shinsetsu-bunkatsu) in which LAPIS established a new company, LAPIS Technology Co., Ltd. ("LAPIS Technology") and LAPIS Technology succeeded LAPIS Semiconductor's LSI business.

Therefore, all references to "LAPIS Semiconductor Co., Ltd.", "LAPIS Semiconductor" and/or "LAPIS" in this document shall be replaced with "LAPIS Technology Co., Ltd."

Furthermore, there are no changes to the documents relating to our products other than the company name, the company trademark, logo, etc.

Thank you for your understanding.

LAPIS Technology Co., Ltd.
October 1, 2020



FEDR45V032A-02

Issue Date: Oct. 22, 2018

MR45V032A

32k Bit(4,096-Word × 8-Bit) FeRAM (Ferroelectric Random Access Memory) SPI

GENERAL DESCRIPTION

The MR45V032A is a nonvolatile 4,096-word x 8-bit ferroelectric random access memory (FeRAM) developed in the ferroelectric process and silicon-gate CMOS technology. The MR45V032A is accessed using Serial Peripheral Interface. Unlike SRAMs, this device, whose cells are nonvolatile, eliminates battery backup required to hold data. This device has no mechanisms of erasing and programming memory cells and blocks, such as those used for various EEPROMs. Therefore, the write cycle time can be equal to the read cycle time and the power consumption during a write can be reduced significantly.

The MR45V032A can be used in various applications, because the device is guaranteed for the write/read tolerance of 10¹³ cycles per bit and the rewrite count can be extended significantly.

FEATURES

- 4,096-word × 8-bit configuration (Serial Peripheral Interface : SPI)
- A single $2.7V \sim 3.6V$ (3.3 V typ) power supply

Operating frequency: 15MHz
 Read/write tolerance 10¹³ cycles/bit
 Data retention 10 years

• Guaranteed operating temperature range —40 to 85°C (Extended temperature version)

• Package options:

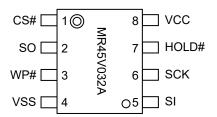
8-pin plastic SOP (P-SOP8-200-1.27-T2K)

• RoHS (Restriction of hazardous substances) compliant



PIN CONFIGURATION

8-pin plastic SOP



Note:

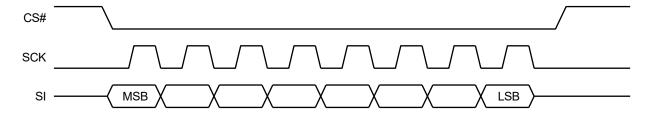
Signal names that end with # indicate that the signals are negative-true logic.

PIN DESCRIPTIONS

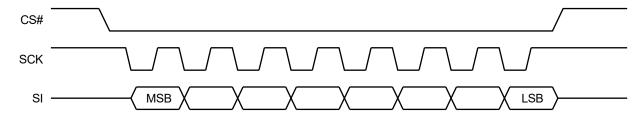
Pin Name	Description
CS#	Chip Select (input, negative logic) Latches an address by low input, activates the FeRAM, and enables a read or write operation.
WP#	Write Protect(input , negative logic) Write Protect pin controls write-operation to the status-register(BP0,BP1). This pin should be fixed low or high in write-operations.
HOLD#	HOLD(input , negative logic) Hold pin is used when the serial-communication suspended without disable the chip select. When HOLD# is low, the serial-output is in High-Z status and serial-input/serial-clock are "Don't Care" . CS# should be low in hold operation.
SCK	Serial Clock Serial Clock is the clock input pin for setting for serial data timing. Inputs are latched on the rising edge and output occur on the falling edge.
SI	Serial input SI pins are serial input pins for Operation-code , addresses ,and data-inputs .
SO	Serial output SO pins are serial output pins.
V _{CC} , V _{SS}	Power supply $ \text{Apply the specified voltage to V_{CC}. Connect V_{SS} to ground. } $

SPI Interface

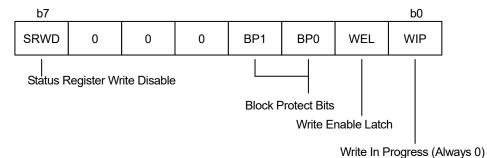
SPI mode0 (CPOL=0, CPHA=0)



SPI mode3 (CPOL=1, CPHA=1)



Status Register



Name	Function
WIP	Fixed to 0.
WEL	WEL indicates internal Write Enable Latch status. The WEL is set after WREN command. After WRDI command, WRSR command, WRITE command, or Power on, the WEL can be reset.
BP0,BP1	Block Protect :These bits can be changed protect area .
	This is the software protect.
SRWD	Status Register Write Disable (SRWD): SRWD controls the effect of the hardware WP# pin. This device will be in hardware-protect by combination of SRWD and WP#.
0	Fixed to 0.

Status Register data are volatile.

Set Status Register data by WRSR(Write status register) command, after power on.

Operation-Code

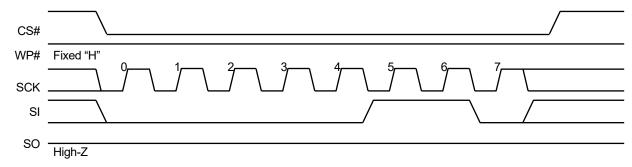
Operation codes are listed in the table below. If the device receives invalid operation code, the device will be diselected.

Instruction	Description	Instruction format
WREN	Write Enable	0000 0110
WRDI	Write Disable	0000 0100
RDSR	Read Status Register	0000 0101
WRSR	Write Status Register	0000 0001
READ	Read from Memory Array	0000 0011
WRITE	Write to Memory Array	0000 0010

Commands

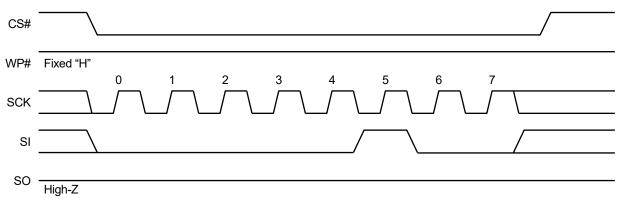
WREN(Write Enable)

It is necessary to set Write Enable Latch (WEL) bit before write-operation (WRITE and WRSR). WREN command sets WEL bit.



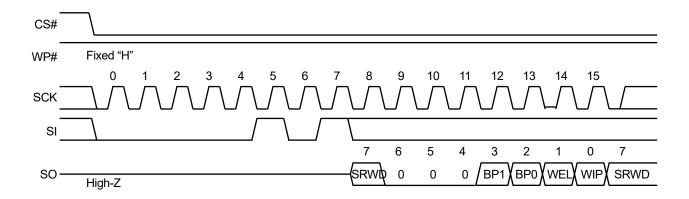
WRDI(Write Disable)

WRDI command resets WEL bit.



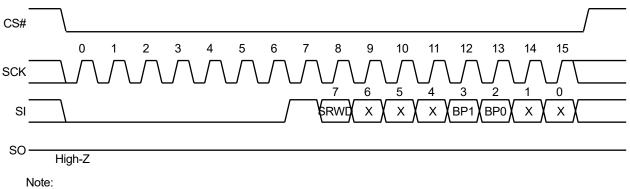
RDSR(READ Status Register)

The RDSR command allows to read data of status register. The Status Register can be read anytime and any number of times.



WRSR(WRITE Status Register)

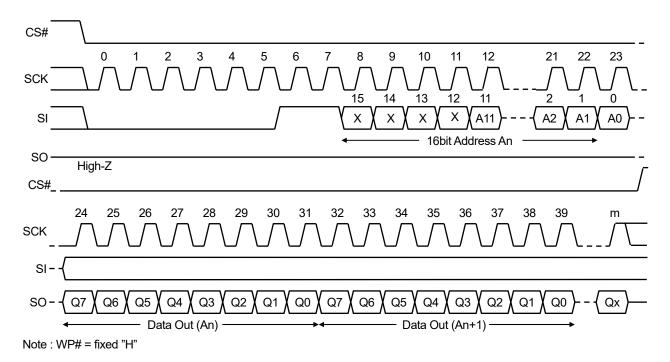
WRSR command allows to write data to status register(SRWD,BP0,BP1). It is necessary to set Write Enable Latch (WEL) bit by WREN command before executing WRSR. WRSR command cannot write RFU(b6,b5,b4), WEL(b1), WIP(b0) of Status Resistor.



WP#=Fix "H"

READ(Read from Memory Array)

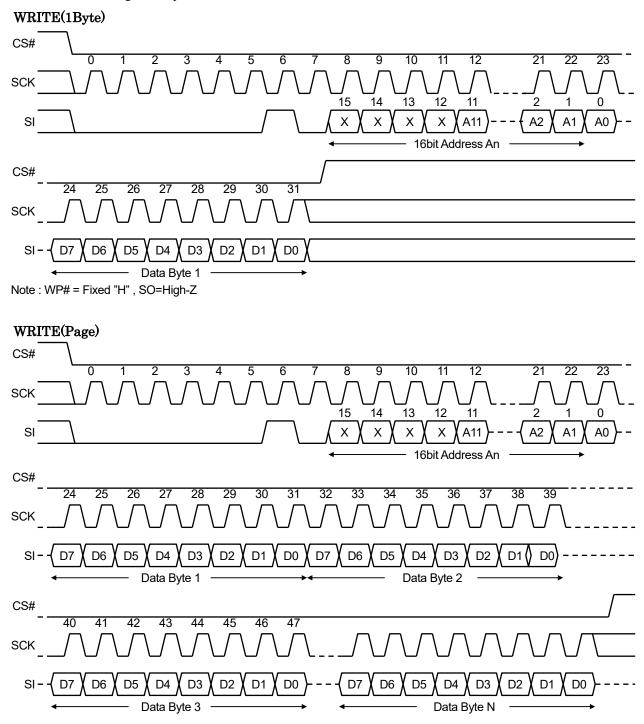
READ command can be valid when CS# goes "L", then the op-code and 16bit-adresses are inputted to serial input "SI". The inputted addresses are loaded to internal register, and then the data from corresponded address is output at serial-output "SO". If CS# will keep "L", the internal address will be increased automatically after 8 clocks and will output the data from new-address. When it reaches the most significant address, the address counter rolls over to starting address, and reading cycle can be continued infinitely. To finish read cycle, make the CS# "H" during LSB output clock.



WRITE(Write to Memory Array)

Note: WP# = Fixed "H", SO=High-Z

Write command can be valid when CS# goes "L", then the op-code and 16bit-adresses are inputted to serial input "SI". Writing is terminated when CS# goes high after data-input. If CS# will keep "L", the internal address will be increased automatically. When it reaches the most significant address, the address counter rolls over to starting address 0000h,and writing cycle(overwriting) can be continued infinitely. To finish write cycle, make CS# "H" during LSB input clock.



Write Protection

Writing protection block is shown as follows:

When Status Resister Write Disable (SRWD) bit is reset to "0", Status Resister number can be changed.

Protect Block size

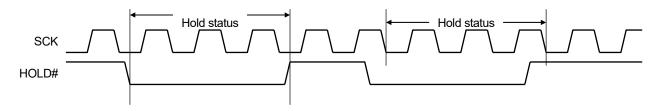
Block Protect BIT		Protected Block	Protected Address Area	
	BP1	BP0	Protected block	Protected Address Area
0		0	None	None
0		1	Upper 1/4 block	C00h – FFFh
1		0	Upper 1/2 block	800h – FFFh
1		1	All	000h – FFFh

Writing Protect

			Writing protection status	Protection sta	tus in memory	
WP#	SRWD	mode	in status register	Protected blocks	Unprotected blocks	
1	0	0.5	Status register is			
0	0	Software protection (SPM)	unprotected when WEL-bit is set by WREN command. BP0 and BP1	Protected	Unprotected	
1	1	(61 111)	are unprotected.			
0	1	Hardware protection (HPM)	Status register is protected. BP0 and BP1 are protected.	Protected	Unprotected	

HOLD

Hold status is used for suspending serial communication without disable the chip. SO becomes "High-Z" and SI is "Don't care" during the hold status. It is necessary to keep CS#=L in hold status.



ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings

The application of stress (voltage, current, or temperature) that exceeds the absolute maximum rating may damage the device. Therefore, do not allow actual characteristics to exceed any one parameter ratings

Pin voltages

Parameter	Symbol	Rat	Unit	
Farameter	Symbol	Min.	Max.	Offic
Pin Voltage (Input Signal)	V_{IN}	-0.5	V _{CC} + 0.5	V
Pin Voltage (Input/Output Voltage)	V _{INQ} , V _{OUTQ}	-0.5	V _{CC} + 0.5	V
Power Supply Voltage	V_{CC}	-0.5	4.0	V

Temperature Range

Darameter	Symbol	Rat	ting	Unit	Note
Parameter	Symbol	Min.	Max.	Offic	
Storage Temperature (Extended Temperature Version)	Tstg	-55	125	°C	
Operating Temperature (Extended Temperature Version)	Topr	-40	85	°C	

Others

Parameter	Symbol	Rating	Note
Power Dissipation	P_{D}	1,000mW	
Allowable Input Current	I _{IN}	+/- 20mA	Ta=25°C
Allowable Output Current	I _{OUT}	+/- 20mA	

Recommended Operating Conditions

Power Supply Voltage

Parameter	Symbol	Min.	Тур.	Max.	Unit
Power Supply Voltage	V _{CC}	2.7	3.3	3.6	V
Ground Voltage	V_{SS}	0	0	0	V

DC Input Voltage

Parameter	Symbol	Min.	Max.	Unit
Input High Voltage	V _{IH}	V _{CC} x 0.8	V _{CC} +0.3	V
Input Low Voltage	V_{IL}	-0.3	V _{CC} x 0.2	V

Overshoot/Undershoot tolerance

Parameter	Parameter Symbol		Peak
"H" input	V _{IH OVERSHOOT}	≤ 20ns	V _{CC} +1.0V
"L" input	V _{IL UNDERSHOOT}	≤ 20ns	– 1.0V

DC Characteristics

DC Input/Output Characteristics

Parameter	Symbol	Condition	Min.	Max.	Unit	Note
Output High Voltage	V _{OH}	I _{OH} =-2mA	V _{CC} × 0.85	1	٧	
Output Low Voltage	V _{OL}	I _{OL} =2mA	_	V _{CC} × 0.15	V	
Input Leakage Current	I _{LI}	_	-10	10	μA	
Output Leakage Current	I _{LO}	_	-10	10	μΑ	

Power Supply Current

V_{CC}=Max.to Min, Ta=Topr

Parameter	Symbol	Condition	Max.	Unit	Note
Power Supply Current (Standby)	I _{ccs}	V _{IN} =0.2V or V _{CC} -0.2V	400	μΑ	1
Power Supply Current (Operating)	I _{CCA}	V_{IN} =0.2V or V_{CC} =0.2V, SCK=15MHz, I_{OUT} =0mA	10	mA	1

Note: 1. Average electric current.

AC Characteristics

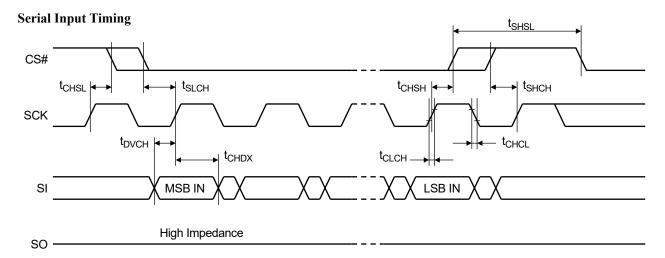
V_{CC}=Max. to Min., Ta=Topr.

_	Symbol	MR45V032A			
Parameter		Min.	Max.	Unit	Note
Clock frequency	f _C	D.C.	15	MHz	
CS# Active setup time	t _{SLCH}	10	_	ns	
CS# In-active setup-time	t _{SHCH}	10	_	ns	
CS# De-select time	t _{SHSL}	10	_	ns	
CS# Active hold time	t _{CHSH}	10	_	ns	
CS# In-active hold-time	t _{CHSL}	10	_	ns	
SCK High time	t _{CH}	30		ns	1
SCK Low time	t _{CL}	30	_	ns	1
SCK Rise time	t _{CLCH}	_	1	ns	2
SCK Fall time	t _{CHCL}	_	1	ns	2
Data Setup time	t _{DVCH}	5	_	ns	
Data Hold time	t _{CHDX}	5	_	ns	
SCK Low Hold time after HOLD# inactive	t _{HHCH}	10	_	ns	
SCK Low Hold time after HOLD# active	t _{HLCH}	10	_	ns	
SCK High Setup time before HOLD# active	t _{CHHL}	10	_	ns	
SCK High Setup time before HOLD# inactive	t _{CHHH}	10	_	ns	
Output disable time	t _{SHQZ}	_	20	ns	2
SCK Low to Output Valid time	t _{CLQV}		35	ns	
Output Hold time	t _{CLQX}	0	_	ns	
Output Rise time	t _{QLQH}	_	50	ns	2
Output Fall time	t _{QHQL}	_	50	ns	2
HOLD# High to Output Low impedance time	t _{HHQX}	_	20	ns	2
HOLD# High to Output High impedance time	t _{HLQZ}	_	20	ns	2

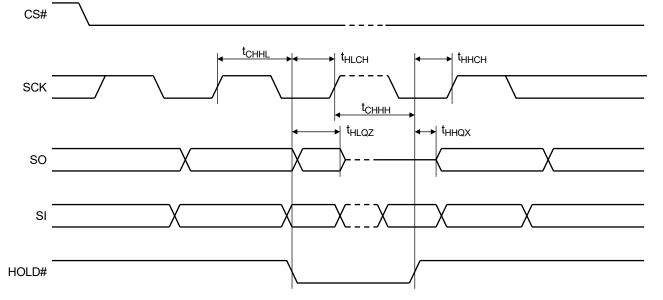
Note: $1. t_{CH} + t_{CL} \square 1/f_C$

2. sample value

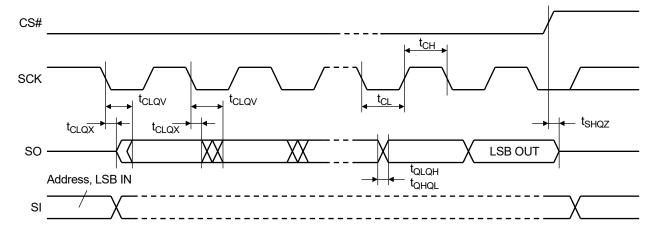
Timing Diagrams



Hold Timing



Output Timing



•Power-On and Power-Off Characteristics

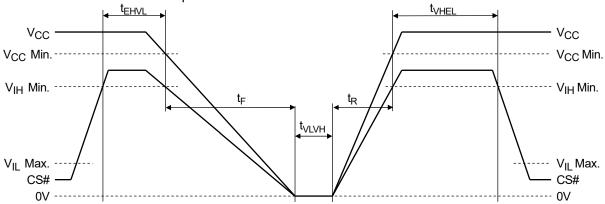
(Under recommended operating conditions)

Parameter	Symbol	Min.	Max.	Unit	Note
Power-On CS# High Hold Time	t _{VHEL}	20	_	μS	1, 2
Power-Off CS# High Hold Time	t _{EHVL}	100	_	ns	1
Power-On Interval Time	t _{VLVH}	1	_	μS	2
Power-On time	tR	50	_	μs/V	
Power-Off time	tF	100	_	μs/V	

Notes:

- 1. To prevent an erroneous operation, be sure to maintain CS#="H", and set the FeRAM in an inactive state (standby mode) before and after power-on and power-off.
- 2. Powering on at the intermediate voltage level will cause an erroneous operation; thus, be sure to power up from 0 V.
- 3. Enter all signals at the same time as power-on or enter all signals after power-on.

•Power-On and Power-Off Sequences



Read/Write Cycles and Data Retention

(Under recommended operating conditions)

Parameter	Min.	Max.	Unit	Note
Read/Write Cycle	10 ¹³	_	Cycle	1
Data Retention	10	_	Year	

Note: 1. Total power on time ≤ 10 years

Capacitance

 V_{CC} = 3.3V, V_{IN} = V_{OUT} = GND, f = 1MHz, and Ta = 25°C

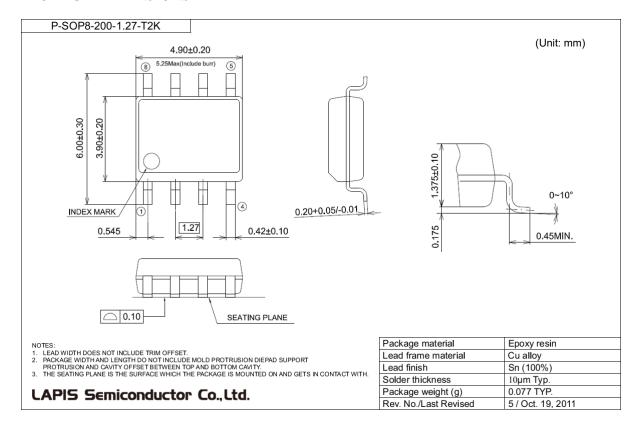
Signal	Symbol	Min.	Max.	Unit	Note
Input Capacitance	C _{IN}	_	10	pF	1
Input/Output Capacitance	C _{OUT}	_	10	pF	1

Note: 1. Sampling value.

ORDERING INFORMATION

Product No.	Package Type (Package Code)	Packing	Temp. Range	
MR45V032AMAZBATL	8-pin plastic SOP (P-SOP8-200-1.27-T2K)	Tape and Reel	−40 to 85°C	

PACKAGE DIMENSIONS



Notes for Mounting the Surface Mount Type Package

The surface mount type packages are very susceptible to heat in reflow mounting and humidity absorbed in storage. Therefore, before you perform reflow mounting, contact a ROHM sales office for the product name, package name, pin number, package code and desired mounting conditions (reflow method, temperature and times).

REVISION HISTORY

	Date	Page			
Document No.		Previous Edition	Current Edition	Description	
FEDR45V032A-01	Oct. 23, 2013	-	ı	Final edition 1	
FEDR45V032A-02	Oct. 22, 2018	- 1 3 11 1, 17 - 21	- 1 3 11 1, 17	Decrease the number of pages Changed New company logo. Added a reset condition of WEL. Corrected writing error: Unit→Note Changed Read/write tolerance : 10 ¹² cycles →10 ¹³ cycles Added ordering information Changed Notes	

Notes

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2-4-8 Shinyokohama, Kouhoku-ku, Yokohama 222-8575, Japan http://www.lapis-semi.com/en/